### PD - 94806

# International

# IRFPG50PbF

HEXFET<sup>®</sup> Power MOSFET

 $V_{\rm DSS} = 1000V$ 

 $R_{DS(on)} = 2.0\Omega$ 

 $I_{\rm D} = 6.1 {\rm A}$ 

D

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Lead-Free

### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial–industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.



### Absolute Maximum Ratings

	0		
	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, VGS @ 10 V	6.1	
lo @ Tc = 100°C	Continuous Drain Current, VGS @ 10 V	3.9	A
I <sub>DM</sub>	Pulsed Drain Current ①	24	
P <sub>D</sub> @ T <sub>C</sub> ≈ 25°C	Power Dissipation	190	W
	Linear Derating Factor	1.5	W/ºC
V <sub>GS</sub>	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	800	mJ
I <sub>AR</sub>	Avalanche Current ①	6.0	А
ÊAR	Repetitive Avalanche Energy ①	19	mJ
dv/dt	Peak Diode Recovery dv/dt ③	1.0	V/ns
TJ	Operating Junction and	-55 to +150	1
TSTG	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1 N•m)	

### **Thermal Resistance**

	Parameter	Min.	Тур.	Max.	Units
Rejc	Junction-to-Case			0.65	
Recs	Case-to-Sink, Flat, Greased Surface		0.24		°C/W
RIJA	Junction-to-Ambient		_	40	

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i i	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
V(BR)DSS	Drain-to-Source Breakdown Voltage	1000			V	V <sub>GS</sub> =0V, I <sub>D</sub> = 250μA	
ΔV <sub>(BR)DSS</sub> /ΔTJ	Breakdown Voltage Temp. Coefficient		1.2	_	V/°C	Reference to 25°C, Ip= 1mA	
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance	_		2.0	Ω	V <sub>GS</sub> ⇔10V, I <sub>D</sub> =3.6A ④	
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	٧	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> = 250µA	
9ts	Forward Transconductance	5.4	—	—	S	V <sub>DS</sub> =100V, I <sub>D</sub> =3.6A ④	
IDSS	Drain-to-Source Leakage Current	—	—	100	μA	V <sub>DS</sub> =1000V, V <sub>GS</sub> =0V	
		_	_	500		V <sub>DS</sub> =800V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C	
	Gate-to-Source Forward Leakage		—	100	- 1	V <sub>GS</sub> =20V	
IGSS	Gate-to-Source Reverse Leakage	I		-100	ПА	V <sub>GS</sub> =-20V	
Qg '	Total Gate Charge		—	190		I <sub>D</sub> =6.1A	
Q <sub>gs</sub>	Gate-to-Source Charge			23	nC	V <sub>DS</sub> =400V	
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge	·		110		V <sub>GS</sub> =10V See Fig. 6 and 13 ④	
t <sub>d (on)</sub>	Turn-On Delay Time	—	19	-		V <sub>DD</sub> =500V	
tr	Rise Time	-	35		ne	I <sub>D</sub> =6.1A	
t <sub>d(off)</sub>	Turn-Off Delay Time		130	—	113	R <sub>9</sub> ≈6.2Ω	
t <sub>f</sub>	Fall Time	-	36	_		$R_D=81\Omega$ See Figure 10 $\oplus$	
LD	Internal Drain Inductance	_	5.0			Between lead, 6 mm (0.25in.)	
Ls	Internal Source Inductance	_	13			and center of die contact	
Ciss	Input Capacitance		2800	_		V <sub>GS</sub> =0V	
Coss	Output Capacitance		250	_	рF	V <sub>DS</sub> =25V	
Crss	Reverse Transfer Capacitance	_	84	_		f=1.0MHz See Figure 5	

### Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

#### **Source-Drain Ratings and Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current (Body Diode)		-	6.1	_	MOSFET symbol showing the
ISM	Pulsed Source Current (Body Diode) ①	_	_	24		integral reverse
VsD	Diode Forward Voltage	_		1.8	V	T_=25°C, IS=6.1A, VGS=0V ⊗
trr	Reverse Recovery Time		630	950	ns	T <sub>J</sub> =25°C, I <sub>F</sub> =6.1A
Qır	Reverse Recovery Charge	·	3.5	5.3	μC	di/dt=100A/μs ⊛
t <sub>on</sub>	Forward Turn-On Time	Intrinsi	Intrinsic turn-on time is neglegible (turn-on is dominated by $L_{S}+L_{D}$ )			

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ③ Isp≤6.1A, di/dt≤120A/µs, Vpp≤600 , TJ≤150°C
- ② V<sub>DD</sub>=50V, starting T<sub>J</sub>=25°C, L=40mH  $R_{G}{=}25\Omega,$   $I_{AS}{=}6.1A$  (See Figure 12)

④ Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$ 2%.

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Fig 1. Typical Output Characteristics

Y<sub>DS</sub> 20us

VGS, Gate-to-Source Voltage (volts)

Fig 3. Typical Transfer Characteristics

100N PULSE WIDTH

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 $10^{1}$ 

10<sup>0</sup>

20<sup>-1</sup>

I<sub>D</sub>, Drain Current (Amps)

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Fig 10a. Switching Time Test Circuit



Fig 10b. Switching Time Waveforms



Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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Fig 13a. Basic Gate Charge Waveform



Fig 12c. Maximum Avalanche Energy Vs. Drain Current



Fig 13b. Gate Charge Test Circuit

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# Peak Diode Recovery dv/dt Test Circuit

\*  $V_{GS}$  = 5V for Logic Level Devices

#### Fig 14. For N-Channel HEXFETS

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### International **TGR** Rectifier

# **TO-247AC** Package Outline

Dimensions are shown in millimeters (inches)



# **TO-247AC Part Marking Information**



Data and specifications subject to change without notice.

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IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 TAC Fax: (310) 252-7903 10/03

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